## Notice of References Cited

Application/Control No. 10/790,994	Applicant(s)/Patent Under Reexamination TSAI ET AL.		
Examiner	Art Unit		
Viet Q Nguyen	2818	Page 1 of 1	

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,721,204	04-2004	Yeh et al.	365/185.24
	В	US-6,490,205	12-2002	Wang et al.	365/185.29
	С	US-6,614,694	09-2003	Yeh et al.	365/185.29
	D	US-2003/0103384	06-2003	Takahashi, Satoshi	365/185.28
	E	US-6,438,031	08-2002	Fastow, Richard M.	365/185.18
	F	US-6,445,030	09-2002	Wu et al.	257/315
	G	US-5,633,178	05-1997	Kalnitsky, Alexander	438/288
	Н	US-6,477,088	11-2002	Ogura et al.	365/185.29
	-	US-2003/0081460	05-2003	Choi et al.	365/185.29
	J	US-6,429,063	08-2002	Eitan, Boaz	438/232
	К	US-		. *	
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	·				
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	٧	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.